

AUTOMOTIVE CURRENT TRANSDUCER OPEN LOOP TECHNOLOGY HAH1BVW S/02





Introduction

The HAH1BVW family is for the electronic measurement of DC, AC or pulsed currents in high power and low voltage automotive applications with galvanic separation between the primary circuit (high power) and the secondary circuit (electronic circuit).

The HAH1BVW family gives you the choice of having different current measuring ranges in the same housing.

Features

- Ratiometric transducer
- · Open Loop transducer using the Hall effect
- Low voltage application
- Unipolar +5 V DC power supply
- Primary current measuring range ±200 A
- · Maximum RMS primary admissible current: defined by busbar to have T < +150 °C
- Operating temperature range: -40 °C < T < +125 °C
- Output voltage: full ratio-metric (in sensitivity and offset).

Advantages

- **Excellent accuracy**
- Very good linearity
- Very low thermal offset drift
- Very low thermal sensitivity drift
- Galvanic separation
- Non intrusive solution.

Automotive application

· Battery Management.

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Principle of HAH1BVW Family

The open loop transducers uses a Hall effect integrated circuit. The magnetic flux density B, contributing to the rise of the Hall voltage, is generated by the primary current I_p to be measured.

The current to be measured I_p is supplied by a current source i.e. battery or generator (Figure 1).

Within the linear region of the hysteresis cycle, B is proportional

$$B(I_{\mathsf{P}}) = a \times I_{\mathsf{P}}$$

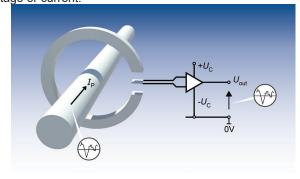
The Hall voltage is thus expressed by:

$$U_{\mathsf{H}} = (c_{\mathsf{H}}/d) \times I_{\mathsf{H}} \times a \times I_{\mathsf{P}}$$

Except for I_{p} , all terms of this equation are constant. Therefore:

$$U_{\mathrm{H}} = b \times I_{\mathrm{p}}$$
 a constant
 b constant
 c_{H} Hall coefficient
 d thickness of the Hall plate
 I_{H} current across the Hall plates

The measurement signal $U_{\rm H}$ amplified to supply the user output voltage or current.



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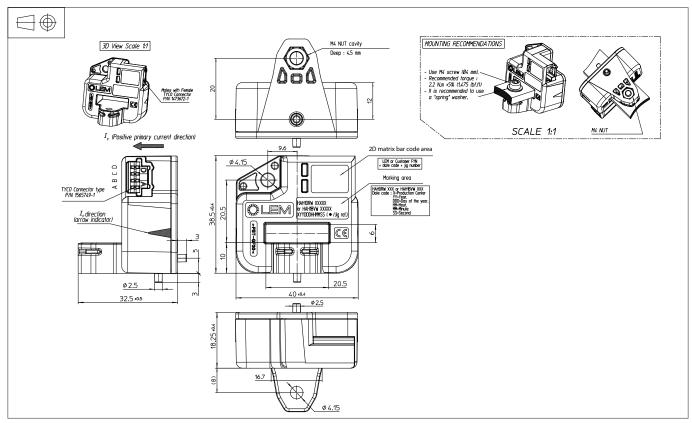
Fig. 1: Principle of the open loop transducer.

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LEM reserves the right to carry out modifications on its transducers, in order to improve them, without prior notice in order to improve them, without prior notice



Dimensions (in mm)



Mechanical characteristics

Plastic case
 PBT GF30

Magnetic core
 FeSi wound core

Mass 57 g ±5 %

Pins Brass tin plated

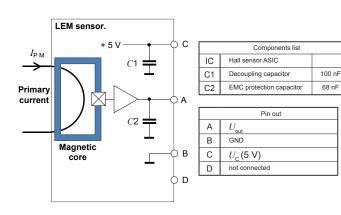
■ IP level IPx2

Mounting recommendation

Mating connector type
 TYCO connector P/N 1473672-1

Assembly torque
 2.2 N·m ±5 %.

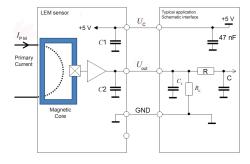
Electronic schematic



Remark

• $U_{\rm out}$ > $U_{\rm o}$ when $I_{\rm p}$ flows in the positive direction (see arrow on drawing).

System architecture (example)



 $C_{\rm L}$ < 100 nF EMC protection (optional) RC Low pass filter (optional)

On board diagnostic

 R_L > 10 kΩ. Resistor for signal line diagnostic (optional)

U_{out}	Diagnostic
Open circuit	<i>U</i> _{IN} ≤ 0.15 V
Short GND	$U_{IN} \le 0.15 \text{ V}$

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Absolute ratings (not operating)

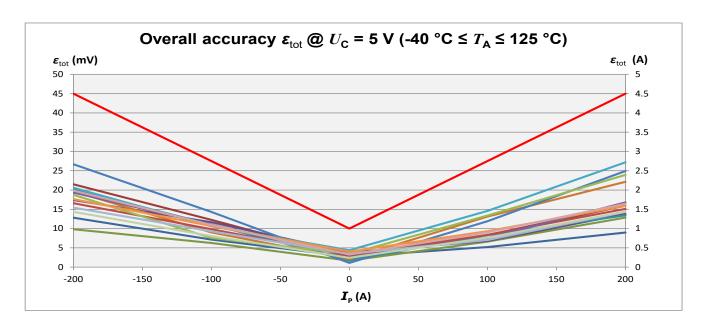
Parameter	Symbol	Unit	Specification			Conditions	
Faranietei	Syllibol		Min	Typical	Max	Collations	
Maximum supply voltage	$U_{\mathrm{C\ max}}$	V			14		
Maximum reverse supply voltage	$U_{\mathrm{C\ max}}$	V	-14				
Maximum output voltage	$U_{\rm outmax}$	V	-14		14	$U_{ m out}$ Reverse / Forward voltage	
Maximum output current	$I_{ m out\; max}$	mA	-10		10		
Ambient storage temperature	$T_{\rm S}$	°C	-40		125		
Electrostatic discharge voltage (HBM - Human Body Model)	$U_{\rm ESD\; HBM}$	kV			8		
Maximum admissible vibration (random RMS)	$\gamma_{\rm max}$	m·s⁻²			96.6	10 to 2000 Hz, -40 °C to 125 °C	
RMS voltage for AC insulation test	U_{d}	kV			2.5	50 Hz, 1 min	
Creepage distance	d_{Cp}	mm	4.85				
Clearance	d_{CI}	mm	4.85				
Comparative traking index	CTI			PLC3			

Operating characteristics in nominal range ($I_{\rm P\,N}\!)$

Paramatan.	Ohl	1124	Specification		tion	O and this ma		
Parameter	Symbol	Unit	Min	Typical	Max	Conditions		
Electrical Data								
Primary current, measuring range	I_{PM}	А	-200		200			
Primary nominal RMS current	I_{PN}	Α	-200		200			
Supply voltage	U_{c}	V	4.5	5	5.5			
Ambient operating temperature	T_{A}	°C	-40		125			
Output voltage	$U_{ m out}$	V	$U_{\text{out}} = (U_{\text{C}}/5) \times (U_{\text{o}} + S \times I_{\text{P}})$					
Sensitivity	S	mV/A		10		@ T _A = 25 °C		
Offset voltage	U_{o}	V		2.5				
Output resolution		mV		2.5				
Output clamping high voltage	$U_{\rm SZ}$		4.74			@ U _c = 5 V		
Output clamping low voltage	$U_{\rm SZ}$				0.26	@ U _c = 5 V		
0 1 "				7		$\textcircled{@}\ T_{\text{A}} = 25\ ^{\circ}\text{C}, \textcircled{@}\ U_{\text{C}} = 5\ \text{V}$		
Current consumption	$I_{\rm C}$	mA			10			
Load resistance	R_{L}	ΚΩ	10					
0.1.11.1.11		Ω		1		@ T _A = 25 °C		
Output internal resistance	R _{out}				10			
	•	Perf	ormance	Data				
Ratiometricity error	ε_{r}	%		±0.2				
Sensitivity error	$\varepsilon_{_{S}}$	%		±1		$\textcircled{@}\ T_{\text{A}}$ = 25 °C, $\textcircled{@}\ U_{\text{C}}$ = 5 V		
Electrical offset voltage	$U_{\mathrm{O}\mathrm{E}}$	mV		±2.5		$\textcircled{@} T_{A} = 25 ^{\circ}\text{C}, \textcircled{@} U_{C} = 5 \text{V}$		
Magnetic offset voltage	U_{OM}	mV		±2		$\textcircled{@}~U_{\text{C}}$ = 5 V, $\textcircled{@}~T_{\text{A}}$ = 25 °C		
Linearity error	ε_{L}	%	-1		1	% of full scale		
Average temperature coefficient of $U_{\rm OE}$	TCV _{OEAV}	mV/°C		±0.06				
Average temperature coefficient of S	TCS AV	%/°C		±0.02				
Step response time @ 90 %	t _r	ms			10			
Frequency bandwidth	BW	Hz		70		@ -3 dB		
Peak-to-peak noise voltage	$U_{ m nopp}$	mV			10	DC to 1 MHz		
Output RMS noise voltage	U_{no}	mV			1.6			
Start-up time	t _{start}	ms			1			
Setting time after overload	t _s	ms			10			



Overall accuracy ϵ_{tot}

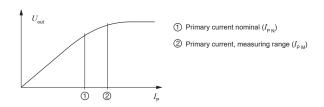


	Overall accuracy ε _{tot} specification							
<i>I</i> _P (A)		/pical value $^{\circ}$ 25 °C, $U_{ m c}$ =		Maximum values −40 °C ≤ T_A ≤ 125 °C, U_c = 5 V				
-200	25 mV	2.50 A	1.25 %	45 mV	4.50 A	2.25 %		
0	7 mV	0.70 A	0.35 %	10 mV	1.00 A	0.50 %		
200	25 mV	2.50 A	1.25 %	45 mV	4.50 A	2.25 %		



PERFORMANCES PARAMETERS DEFINITIONS

Primary current definition:



Definition of typical, minimum and maximum values:

Minimum and maximum values for specified limiting and safety conditions have to be understood as such as values shown in "typical" graphs. On the other hand, measured values are part of a statistical distribution that can be specified by an interval with upper and lower limits and a probability for measured values to lie within this interval. Unless otherwise stated (e.g. "100 % tested"), the LEM definition for such intervals designated with "min" and "max" is that the probability for values of samples to lie in this interval is 99.73 %. For a normal (Gaussian) distribution, this corresponds to an interval between -3 sigma and +3 sigma. If "typical" values are not obviously mean or average values, those values are defined to delimit intervals with a probability of 68.27 %, corresponding to an interval between -sigma and +sigma for a normal distribution. Typical, minimum and maximum values are determined during the initial characterization of a product.

Output noise voltage:

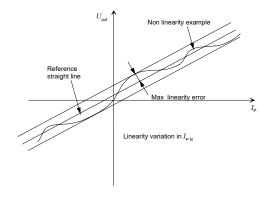
The output voltage noise is the result of the noise floor of the Hall elements and the linear amplifier.

Magnetic offset:

The magnetic offset is the consequence of an any current on the primary side. It's defined after a stated excursion of primary current.

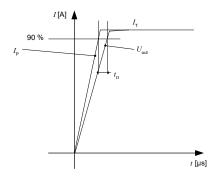
Linearity:

The maximum positive or negative discrepancy with a reference straight line $U_{\rm out}$ = $f(I_{\rm p})$. Unit: linearity (%) expressed with full scale of $I_{\rm P\,N}$.



Response time (delay time) $t_{D ext{ 90}}$:

The time between the primary current signal (I_{PN}) and the output signal reach at 90 % of its final value.



Sensitivity:

The transducer's sensitivity S is the slope of the straight line $U_{\text{out}} = f(I_{\text{p}})$, it must establish the relation:

$$U_{\text{out}}(I_{\text{P}}) = U_{\text{C}}/5 (S \times I_{\text{P}} + U_{\text{O}})$$

Offset with temperature:

The error of the offset in the operating temperature is the variation of the offset in the temperature considered with the initial offset at 25 °C.

The offset variation $I_{\text{O}\,\textsc{T}}$ is a maximum variation the offset in the temperature range:

$$I_{OT} = I_{OE} \max - I_{OE} \min$$

The offset drift $TCI_{\text{O E AV}}$ is the $I_{\text{O }T}$ value divided by the temperature range.

Sensitivity with temperature:

The error of the sensitivity in the operating temperature is the relative variation of sensitivity with the temperature considered with the initial offset at 25 °C.

The sensitivity variation $S_{\scriptscriptstyle T}$ is the maximum variation (in ppm or %) of the sensitivity in the temperature range: S_{τ} = (Sensitivity max - Sensitivity min) / Sensitivity at 25 °C.

The sensitivity drift TCS _{AV} is the $S_{\mathcal{T}}$ value divided by the temperature range. Deeper and detailed info available is our LEM technical sales offices (www.lem.com).

Offset voltage @ $I_D = 0$ A:

The offset voltage is the output voltage when the primary current is zero. The ideal value of U_0 is $U_c/2$. So, the difference of $U_{\rm o}$ – $U_{\rm c}/2$ is called the total offset voltage error. This offset error can be attributed to the electrical offset (due to the resolution of the ASIC quiescent voltage trimming), the magnetic offset, the thermal drift and the thermal hysteresis. Deeper and detailed info available is our LEM technical sales offices (www.lem. com).

Environmental test specifications:

Refer to LEM GROUP test plan laboratory CO.11.11.515.0 with "Tracking_Test Plan_Auto" sheet.

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Environmental test specifications:

Refer to LEM GROUP test plan laboratory CO.11.11.515.0 with "Tracking_Test Plan_Auto" sheet.

Name	Standard					
CHARACTERIZATION @ 25 °C						
Sensitivity / Accuracy / Overall accuracy	LEM 98.20.00.574.0					
Offset / Electrical Offset / Magnetic Offset	LEM 98.20.00.573.0					
Linearity error	LEM 98.20.00.370.0					
Current Consumption	LEM 98.20.00.579.0					
CHARACTERIZATION WITH T °C (initial)						
Sensitivity / Accuracy / Overall accuracy	LEM 98.20.00.574.0					
T °C variation of / Temperature Coefficient of S	LEM 98.20.00.574.0					
Offset / Electrical Offset / Magnetic Offset	LEM 98.20.00.573.0					
T °C variation of /Temperature Coefficient of Offset	LEM 98.20.00.573.0					
Linearity error	LEM 98.20.00.370.0					
Current Consumption	LEM 98.20.00.579.0					
ELECTRICAL TESTS @ 25 °C						
Dielectric withstand Voltage test	2500 V AC / 1 min / 50 Hz					
Insulation resistance test	500 V DC , time = 60 s $R_{\text{INS}} ≥ 500 \text{ M}Ω$ Minimum					
ENVIRONMENTAL TESTS (CLIMATIC)						
Thermal shock	IEC 60068-2-14 Na (01/2009)					
Steady state T °C Humidity bias life test	JESD 22-A101 (03/2009)					
MECHANICAL TESTS						
Vibration random in T °C	IEC 60068-2-64 (02/2008)					
Shocks	IEC 60068-2-27 (02/2008)					
Free Fall (Device not packaged)	IEC 60068-2-31 §5.2: method 1 (05/2008)					
FINAL CHARACTERIZATION						
Characterization @ 25 °C						
Characterization with temperature						

单击下面可查看定价,库存,交付和生命周期等信息

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